

Report No.: EED32L00178102



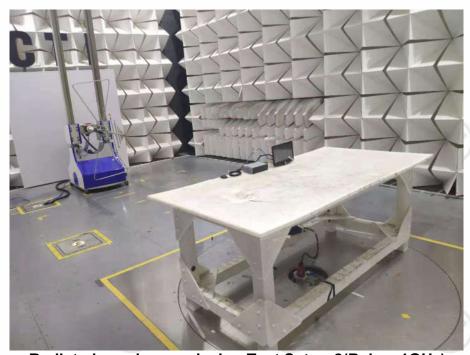




## PHOTOGRAPHS OF TEST SETUP Test model No.: UN1810



Radiated spurious emission Test Setup-1(30MHz-1GHz)



Radiated spurious emission Test Setup-2(Below 1GHz)













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